## 10/532328 JC13 Rec'd PCT/PTO 22 APR 2005

Sheet 1 of 1

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-04798  SERIAL NO. Filed Concurrently Herewith				
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	APPLICANT Satoshi IMAI et al.				
(03000000000000000000000000000000000000	FILING DATE Filed Concurrently Herewith	GROUP			

				Fil	ed Concurrently Herev	vith	<del></del>	
			U.S	S. PATENT DO	CUMENTS	·····		
EXAMINER INITIAL		DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLASS	FILING DATE II APPROPRIATE
/N.C./	AA	6, 339, 681	01/15/02	Takeshita				
	AB						·	
	AG							
	AD							
	AE							
	AF							
	AG							
	AH							
	ΑI							
	AJ				·			
	AK					`		
			FORE	IGN PATENT	DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION YES NO
/N.C./	AL	JP 11-109208	04/23/99	Japan				
/N.C./	AM	JP 7-234443	09/05/95	Japan				
/N.C./	AN	JP 2000-194046	07/14/00	Japan				
	AO							
	AP							
		OTHER P	UOR ART (In	cluding Author	r, Title, Date, Pertinent	Pages, Etc.)		
	-10							
	AR							
	AS	,						
EXAMINER /Nia Cook/				DATE CONSIDERED 06/18/2007				

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FILING DATE IF

APPROPRIATE



**EXAMINER** 

INITIAL

AA

DOCUMENT NUMBER

Based on Ferm PTO-1449
(3/90)

LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

FILING DATE
April 22, 2005

ATTY. DOCKET NO.
10/532,328

APPLICANT
Satoshi IMAI et al.

FILING DATE
April 22, 2005

GROUP
2851

**U.S. PATENT DOCUMENTS** 

NAME

DATE

CLASS

**SUBCLASS** 

	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	Al							
	AJ							
	AK							
			FOREIC	GN PATENT	DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE		COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL							
	AM						<u> </u>	
	AN							
	AO							
	AР							
		OTHER PR	IOR ART (Inc	luding Autho	r, Title, Date, Pertine	nt Pages, Etc.)		
	AQ	PATENT ABSTRACTS OF JAPAN, publication number 2000-131729, publication date May 12, 2000.						
NC	AK							·· ·
	AS			_				
EXAMINER	/Nia Cook/			DATE CONSIDERED 06/18/2007				
EXAMINE and not contain the second seco	ER: Initial nsidered.	if reference considered, who Include copy of this form wi	ether or not cita th next commu	ntion is in cor nication to ap	oformance with MPE oplicant.	P 609. Draw line	through citation	if not in conformance